



IEC TS 62804-1:2015

Photovoltaic (PV) Modules - Test Methods for the detection of potential-induced degradation

Part 1: Crystalline silicone
Confirmation of test results

File Ref.: 10004/2022-40173

Applicant: Changzhou EGing Photovoltaic Technology Co., Ltd.
No. 18 Jinwu Road, 213213 Jintan City, China

Product: Crystalline silicon Photovoltaic (PV)-Modules

Type:

BI)	EG-XXXM72-HLV	BJ)	EG-XXXM60-HLV
BO)	EG-XXXM54-HLV	BM)	EG-XXXM72-HL/BF-DG
BN)	EG-XXXM60-HL/BF-DG	BQ)	EG-XXXM54-HL/BF-DG
BX)	EG-XXXM66-HUV	BR)	EG-XXXM60-HUV
BS)	EG-XXXM54-HUV	BY)	EG-XXXM66-HU/BF-DG
BV)	EG-XXXM60-HU/BF-DG	BW)	EG-XXXM54-HU/BF-DG

XXX in the type replaces the power in watt and can be any number between:

510 - 550 for BI), BM)	425 - 465 for BJ), BN)
385 - 425 for BO), BQ)	640 - 670 for BX)
585 - 620 for BR)	530 - 555 for BS)
640 - 675 for BY)	585 - 605 for BV)
530 - 545 for BW)	

Manufacturer: Changzhou EGing Photovoltaic Technology Co., Ltd.

Standard: IEC TS 62804-1:2015

Test conditions

Testing time:	96 h
Chamber temperature:	85°C
Relative humidity:	85 %
Potential to ground:	+/- 1500 V

Pass criteria

Power Degradation:	< 5%
Dry Insulation Resistance:	> 40 MΩm ²
Wet Insulation Resistance:	> 40 MΩm ²
Visual Inspection:	No findings



Summary of test results:

Maximum Power Degradation: allowed max. 5 %
measured max. 1.14 %

The measured degradation is below the allowed degradation.

Dry Insulation Resistance: required min. 15.5 M Ω
measured >1000 M Ω

The measured dry insulation resistance is above the min. required dry insulation resistance.

Wet Insulation Resistance: required min. 15.5 M Ω
measured >1000 M Ω

The measured wet insulation resistance is above the minimum required wet insulation resistance.

Visual Inspection: No findings

The complete test results and the relevant bill of materials are given in Test Report No.: TRPVM-2022-40173-1.

The overview of the already approved modules with the approved bill of materials is given in Annex 1, dated 2022-04-05.

VDE Renewables GmbH


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63755 Alzenau, 2022-04-05